

IN THE CLAIMS:

Amend claims 1-13 as shown on the following pages.

1. (Currently Amended). A method of system for maintaining an IC-module near a set-point temperature while electrical power dissipation in said IC-module is varied; said method including the steps system being comprised of:

pressing an open end of a container against said
IC-module such that a leak free seal is formed between said
container and said IC-module;

spraying a liquid coolant onto said IC-module,
during said pressing step, from at least one nozzle in said
container; and,

keeping said IC-module at a set-point which is
colder than the boiling point of said liquid coolant at
atmospheric pressure, by producing a sub-atmospheric
pressure in said container throughout said spraying step.

~~a container having an open end with a seal for~~
~~pressing against said IC-module;~~

~~at least one nozzle, in said container, for~~
~~spraying a liquid coolant on said IC-module when said seal~~
~~is pressed against said IC-module; and~~

~~a pressure reducing means, coupled to said~~
~~container, for producing a sub-atmospheric pressure between~~
~~said container and said IC-module when said seal is pressed~~
~~against said IC-module.~~

2. (Currently Amended). A method system according to claim 1 wherein the temperature of said IC-module is kept, by said pressure reducing means produces said sub-atmospheric pressure, such that the boiling point of said liquid coolant is lowered by at least 10°C below the from its boiling point of said liquid coolant at atmospheric pressure.

3. (Currently Amended). A method system according to claim 2 wherein said pressure reducing means reduces said sub-atmospheric pressure in said container is reduced to a point where essentially all of said liquid coolant from each nozzle rapidly vaporizes when it hits said IC-module.

4. (Currently Amended). A method system according to claim 2 wherein said liquid coolant circulates through which further includes a circulation subsystem which is[[],] coupled to each nozzle, that holds said liquid coolant; and wherein said liquid coolant consists essentially of water.

5. (Currently Amended). A method system according to claim 2 wherein which includes multiple nozzles are at spaced-apart locations in said container, and each nozzle receives includes a means for receiving one control signal and ejects a means for ejecting just a single droplet of said liquid coolant when it receives said one control signal.

6. (Currently Amended). A method system according to claim 5 which further includes the steps of: a—closed-loop control means for: a) receiving a sensor signal representing a sensed temperature of said IC-module, and b) sending said control signal to all of said nozzles simultaneously with a frequency that increases as the differences between said sensed temperature and said set-point increases.

7. (Currently Amended). A method system according to claim 5 which further includes the steps of: a—closed-loop control means for: a) receiving a sensor signal representing a sensed temperature of said IC-module, b) sending said control signal to a subset of said nozzles simultaneously, and c) increasing the number of nozzles in said subset as the difference between said sensed temperature and said set-point increase.

8. (Currently Amended). A method system according to claim 5 wherein said means for ejecting in each nozzle ejects each said single droplet by squeezing said coolant with a piezoelectric device.

9. (Currently Amended). A method system according to claim 5 wherein said means for ejecting in each nozzle ejects each said single droplet by heating said coolant with an electric heater.

10. (Currently Amended). A method system according to claim 2 wherein each nozzle receives includes a means for receiving one control signal and sprays a means for spraying multiple droplets of said liquid coolant when it receives said one control signal.

11. (Currently Amended). A method system according to claim 10 which further includes the steps of: a closed-loop control means for: a) receiving a sensor signal representing a sensed temperature of said IC-module, and b) sending said control signal with an ON-OFF ratio that increases as the difference between said sensed temperature and said set-point increases.

12. (Currently Amended). A method system according to claim 2 wherein said seal is formed by encircling shaped to encircle a surface on said IC-module which encloses an IC-chip.

13. (Currently Amended). A method system according to claim 2 wherein said seal is formed by encircling shaped to encircle an exposed surface on an IC-chip in said IC-module.